Ref #	Hits	Search Query	DBs	Defau It Opera tor	Plur als	Time Stamp
L1 4	2	"EP 802636 A2".did. OR "JP 07143100 A"	EPO; JPO	AND	ON	2005/12/20 06:08
S1	2215	(H03M013/09 OR H03M013/29).ipc.	EPO; JPO; DERWE NT	AND	ON	2005/12/17 08:10
S2	1468	(714/703-704 OR 714/758 OR 714/776).ccls. AND @ad<"20020702"	US-PGP UB; USPAT; USOCR	AND	ON	2005/12/19 11:05
S3	280	(number NEAR error) AND CRC AND FEC	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2005/12/20 05:50
S4	151	number NEAR "bits changed"	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2005/12/17 08:11

S5	12	(number NEAR "bits changed") AND "CRC"	US-PGP UB; USPAT; USOCR ; EPO; JPO; DERWE NT; IBM_T DB	AND	ON	2005/12/17 08:11
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